 Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/010,682	CHU ET AL.		
Examiner	Art Unit		
F. Lin Khoo	2664		

	SEARCHED		
Class	Subclass	Date	Examiner
370	352	11/2/2005	FLK
370	395.52	11/2/2005	FLK
370	310.1	11/2/2005	FLK
370	310.2	11/2/2005	FLK
370	433	11/2/2005	FLK
370	517	11/2/2005	FLK
370	555	11/2/2005	FLK
370	560	11/2/2005	FLK

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
Update Search	11/2/2005	FLK